

# AON7264C

## 60V N-Channel AlphaSGT™

## **General Description**

- Trench Power AlphaSGT<sup>TM</sup> technology
- Low R<sub>DS(ON)</sub>
- Logic Level Gate Drive
- ESD Protected
- Excellent Gate Charge x R<sub>DS(ON)</sub> Product (FOM)
- RoHS 2.0 and Halogen-Free Compliant

## **Applications**

 High Frequency Switching and Synchronous Rectification

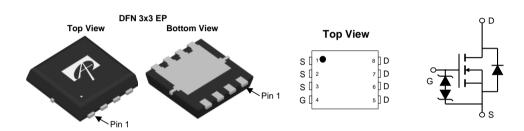
## **Product Summary**

 $\begin{array}{ll} V_{DS} & 60V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 24A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 13.2 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 17.7 m\Omega \end{array}$ 

Typical ESD protection HBM Class 2

100% UIS Tested 100% Rg Tested





	Orderable Part Number	Раскаде туре	Form	Minimum Order Quantity
	AON7264C	DFN 3x3 EP	Tape & Reel	5000
_				

Ratings T <sub>A</sub> =25°C unle	ss otherwise noted			
Parameter		Maximum	Units	
Drain-Source Voltage		60	V	
Gate-Source Voltage		±20	V	
T <sub>C</sub> =25°C	1	24		
T <sub>C</sub> =100°C	'D	20	Α	
Ċ	I <sub>DM</sub>	90		
T <sub>A</sub> =25°C		13	۸	
T <sub>A</sub> =70°C	IDSM	10	A	
Avalanche Current C		14	A	
L=0.3mH <sup>C</sup>	E <sub>AS</sub>	29	mJ	
10µs	V <sub>SPIKE</sub>	72	V	
T <sub>C</sub> =25°C	D	24	W	
T <sub>C</sub> =100°C	L D	9.5	VV	
T <sub>A</sub> =25°C	Р	4.1	\\\	
T <sub>A</sub> =70°C	FDSM	2.6	W	
Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C	
	$T_{C}=25^{\circ}C$ $T_{C}=100^{\circ}C$ $T_{A}=25^{\circ}C$ $T_{A}=70^{\circ}C$ $T_{A}=70^{\circ}C$ $T_{C}=100^{\circ}C$ $T_{C}=100^{\circ}C$ $T_{C}=100^{\circ}C$ $T_{C}=25^{\circ}C$	Symbol   V <sub>DS</sub>   V <sub>GS</sub>   V <sub>G</sub>	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	24	30	°C/W	
Maximum Junction-to-Ambient AD	Steady-State		45	55	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	4.2	5.2	°C/W	



#### Electrical Characteristics (T<sub>.I</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60			V			
I	Zero Gate Voltage Drain Current	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V			1	^			
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	T <sub>J</sub> =55°C			5	μA			
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V			±10	μΑ			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	1.2	1.7	2.2	V			
		V <sub>GS</sub> =10V, I <sub>D</sub> =13A		10.7	13.2	mΩ			
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	T <sub>J</sub> =125°C		17.4	21.3	11122			
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =11A		14	17.7	mΩ			
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =13A		38		S			
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V		0.72	1	V			
Is	Maximum Body-Diode Continuous Curr	ent <sup>G</sup>			24	Α			
DYNAMIC	PARAMETERS								
C <sub>iss</sub>	Input Capacitance			895		pF			
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =30V, f=1MHz		220		pF			
$C_{rss}$	Reverse Transfer Capacitance			20		pF			
$R_g$	Gate resistance	f=1MHz	0.6	1.3	2.0	Ω			
SWITCHI	NG PARAMETERS								
<b>Q</b> <sub>g</sub> (10V)	Total Gate Charge			15	21	nC			
Q <sub>g</sub> (4.5V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =13A		7.5	11	nC			
$Q_{gs}$	Gate Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =30V, I <sub>D</sub> =13A		2.0		nC			
$Q_{gd}$	Gate Drain Charge			3.0		nC			
Q <sub>oss</sub>	Output Charge	$V_{GS}=0V$ , $V_{DS}=30V$		11		nC			
t <sub>D(on)</sub>	Turn-On DelayTime			4		ns			
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =30V, $R_L$ =2.3 $\Omega$ ,		3.5		ns			
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$		25.5		ns			
t <sub>f</sub>	Turn-Off Fall Time	7		4		ns			
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =13A, di/dt=500A/μs		15.5		ns			
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =13A, di/dt=500A/μs		49		nC			

A. The value of  $R_{\text{BJA}}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The Power dissipation P<sub>DSM</sub> is based on R <sub>QJA</sub> t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =150° C.

D. The R<sub>0JA</sub> is the sum of the thermal impedance from junction to case R<sub>0JC</sub> and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>I/(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

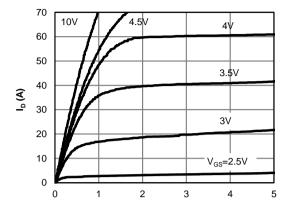
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

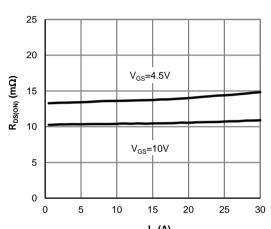
I. The spike duty cycle 5% max, limited by junction temperature  $T_{J(\text{MAX})}\!\!=\!\!125^{\circ}\,$  C.



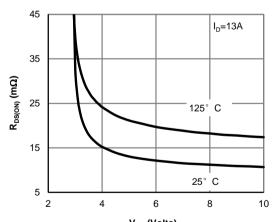
### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



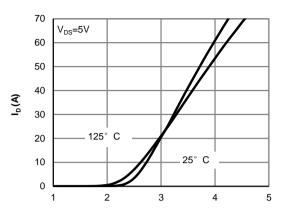
V<sub>DS</sub> (Volts) Figure 1: On-Region Characteristics (Note E)



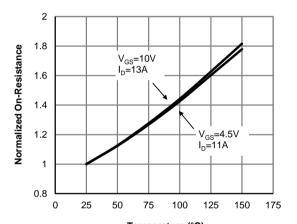
I<sub>D</sub> (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



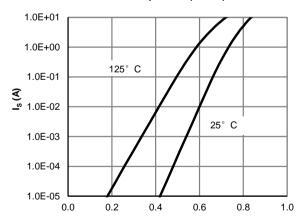
V<sub>GS</sub> (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage
(Note E)



V<sub>GS</sub> (Volts)
Figure 2: Transfer Characteristics (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction
Temperature (Note E)

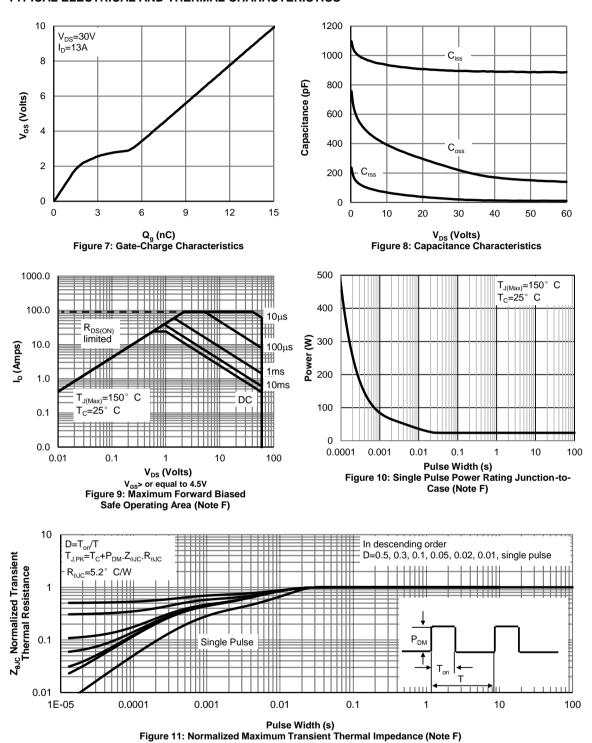


V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)

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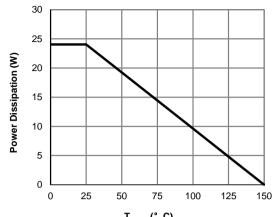


#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

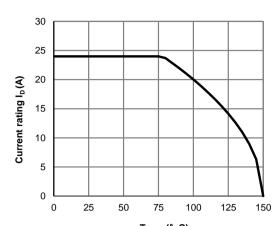




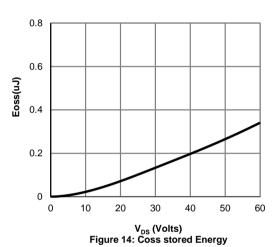
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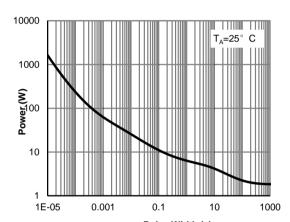


T<sub>CASE</sub> (° C)
Figure 12: Power De-rating (Note F)

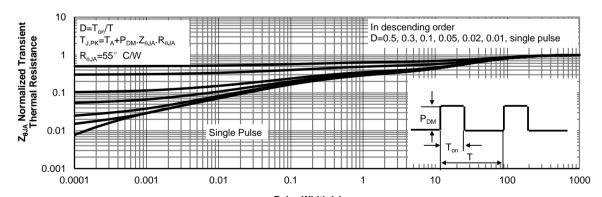


T<sub>CASE</sub> (° C) Figure 13: Current De-rating (Note F)





Pulse Width (s)
Figure 15: Single Pulse Power Rating Junctionto-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

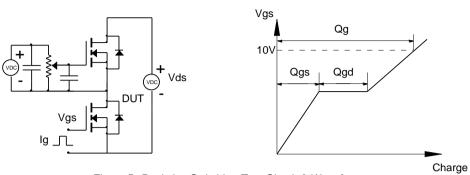


Figure B: Resistive Switching Test Circuit & Waveforms

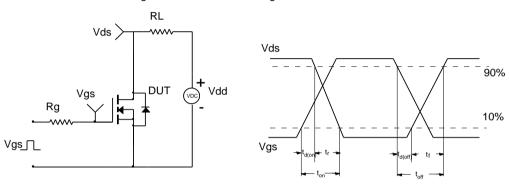


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

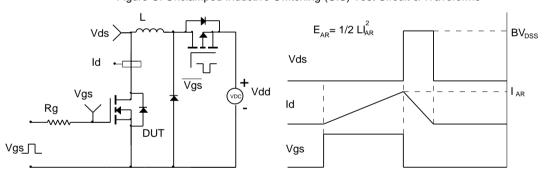


Figure D: Diode Recovery Test Circuit & Waveforms

